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**Ide et al.**

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(54) **ANOMALY DETECTION BASED ON DIRECTIONAL DATA**

(56) **References Cited**

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U.S. PATENT DOCUMENTS  
4,882,733 A 11/1989 Tanner  
5,050,069 A 9/1991 Hillis et al.  
5,127,022 A 6/1992 Takegahara et al.  
(Continued)

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FOREIGN PATENT DOCUMENTS

(\* ) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 1288 days.  
  
This patent is subject to a terminal disclaimer.

JP 10254899 A 9/1998

OTHER PUBLICATIONS

A. Banerjee, et al., "Generative Model-Based Clustering of Directional Data," Proceedings of the Ninth ACM SIGKDD International Conference on Knowledge Discovery and Data Mining, pp. 19-28, 2003.

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See application file for complete search history.

(57) **ABSTRACT**

Properly detects an anomaly on the basis of directional data that are obtained in sequence from a monitored object. An anomaly detecting method includes: sequentially generating directional data indicating a feature of each piece of monitored data correspondingly to the monitored data which are input in sequence; calculating the dissimilarity of the directional data to a reference vector; updating a moment of the distribution of the dissimilarity appearing when the directional data is modeled with a multi-dimensional probability distribution, based on the moment already corresponding to the monitored data; calculating a parameter determining the variance of the multi-dimensional probability distribution, on the basis of the moment; calculating a threshold of the dissimilarity on the basis of the multi-dimensional probability distribution the variance of which is determined by the parameter; and detecting an anomaly in the monitored data that corresponds to the dissimilarity if the dissimilarity exceeds the threshold.

**16 Claims, 10 Drawing Sheets**

